



**HARRIS**

**IRFP9140R/P9141R**  
**IRFP9142R/P9143R**

Avalanche Energy Rated  
P-Channel Power MOSFETs

August 1991

T-39-23

**Features**

- -19A and -16A, -60V and -100V
- $r_{DS(ON)} = 0.20\Omega$  and  $0.30\Omega$
- Single Pulse Avalanche Energy Rated
- SOA is Power-Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance

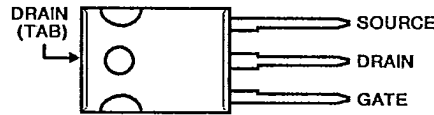
**Description**

The IRFP9140R, IRFP9141R, IRFP9142R and IRFP9143R are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. These are p-channel enhancement-mode silicon-gate power field-effect transistors designed for applications such as switching regulators, switching converters, motor drivers, relay drivers, and drivers for high-power bipolar switching transistors requiring high speed and low gate-drive power. These types can be operated directly from integrated circuits.

The IRFP types are supplied in the JEDEC TO-247 plastic package.

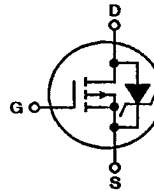
**Package**

TO-247  
TOP VIEW



**Terminal Diagram**

P-CHANNEL ENHANCEMENT MODE



Absolute Maximum Ratings ( $T_C = 25^\circ\text{C}$ ) Unless Otherwise Specified

	IRFP9140R	IRFP9141R	IRFP9142R	IRFP9143R	UNITS
Drain-Source Voltage (1) .....	$V_{DS}$ -100	-60	-100	-60	V
Drain-Gate Voltage ( $R_{GS} = 20k\Omega$ ) (1) .....	$V_{DGR}$ -100	-60	-100	-60	V
Continuous Drain Current					
$T_C = 25^\circ\text{C}$ .....	$I_D$ -19	-19	-16	-16	A
$T_C = 100^\circ\text{C}$ .....	$I_D$ -12	-12	-10	-10	A
Pulsed Drain Current (3) .....	$I_{DM}$ -76	-76	-64	-64	A
Gate-Source Voltage .....	$V_{GS}$ $\pm 20$	$\pm 20$	$\pm 20$	$\pm 20$	V
Maximum Power Dissipation .....	$P_D$ 150	150	150	150	W
(See Figure 14)					
Linear Derating Factor .....	1.2	1.2	1.2	1.2	W/ $^\circ\text{C}$
(See Figure 14)					
Single Pulse Avalanche Energy Rating (4) .....	$E_{AS}$ 960	960	960	960	mJ
Operating and Storage Junction .....	$T_J, T_{STG}$ -55 to +150	-55 to +150	-55 to +150	-55 to +150	$^\circ\text{C}$
Temperature Range					
Maximum Lead Temperature for Soldering .....	$T_L$ 300	300	300	300	$^\circ\text{C}$
(0.063" (1.6mm) from case for 10s)					

**NOTES:**

1.  $T_J = +25^\circ\text{C}$  to  $+150^\circ\text{C}$
2. Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
3. Repetitive Rating: Pulse width limited by max. junction temperature. See Transient Thermal Impedance Curve (Figure 5)
4.  $V_{DD} = 50\text{V}$ , Start  $T_J = +25^\circ\text{C}$ ,  $L = 4.2\text{mH}$ ,  $R_G = 25\Omega$ , Peak  $I_L = 19\text{A}$  (See Figures 15 and 16)

CAUTION: These devices are sensitive to electrostatic discharge. Proper I.C. handling procedures should be followed.  
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File Number **2292**

Specifications IRFP9140R, IRFP9141R, IRFP9142R, IRFP9143R

Electrical Characteristics  $T_C = +25^\circ\text{C}$ , Unless Otherwise Specified

T-39-23

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	LIMITS			UNITS
			MIN	TYP	MAX	
Drain-Source Breakdown Voltage IRFP9140R, IRFP9142R IRFP9141R, IRFP9143R	$BV_{DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-100	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-2.0	-	-4.0	V
Gate-Source Leakage Forward	$I_{GSS}$	$V_{GS} = 20V$	-	-	100	nA
Gate-Source Leakage Reverse	$I_{GSS}$	$V_{GS} = -20V$	-	-	-100	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = \text{Max Rating}, V_{GS} = 0V$ $V_{DS} = \text{Max Rating} \times 0.8, V_{GS} = 0V,$ $T_J = +125^\circ\text{C}$	-	-	250	$\mu A$
On-State Drain Current (Note 2) IRFP9140R, IRFP9141R IRFP9142R, IRFP9143R	$I_{D(ON)}$	$V_{DS} > I_{D(ON)} \times r_{DS(ON)} \text{ Max}, V_{GS} = -10V$	-19	-	-	A
Static Drain-Source On-State Resistance (Note 2) IRFP9140R, IRFP9141R IRFP9142R, IRFP9143R	$r_{DS(ON)}$	$V_{GS} = -10V, I_D = -10A$	-	0.14	0.20	$\Omega$
Forward Transconductance (Note 2)	$g_{fs}$	$V_{DS} \leq -50V, I_D = -10A$	5.3	7.9	-	S( $\Omega$ )
Input Capacitance	$C_{ISS}$	$V_{GS} = 0V, V_{DS} = -25V, f = 1.0\text{MHz}$	-	1200	-	pF
Output Capacitance	$C_{OSS}$	See Figure 10	-	570	-	pF
Reverse Transfer Capacitance	$C_{RSS}$		-	160	-	pF
Turn-On Delay Time	$t_{d(ON)}$	$V_{DD} = -50V, I_D = -19A, R_G = 9.1\Omega$	-	16	20	ns
Rise Time	$t_r$	See Figure 17. (MOSFET switching times are essentially independent of operating temperature.)	-	65	100	ns
Turn-Off Delay Time	$t_{d(OFF)}$		-	47	70	ns
Fall Time	$t_f$		-	28	70	ns
Total Gate Charge (Gate-Source + Gate-Drain)	$Q_g$	$V_{GS} = -10V, I_D = -19A, V_{DS} = 0.8 \text{ Max Rating}$ . See Figure 18 for test circuit. (Gate charge is essentially independent of operating temperature.)	-	37	55	nC
Gate-Source Charge	$Q_{gs}$		-	8.7	-	nC
Gate-Drain ("Miller") Charge	$Q_{gd}$		-	22	-	nC
Internal Drain Inductance	$L_D$	Measured between contact screw on header that is closer to source & gate pins & center of die.	-	5.0	-	nH
Internal Source Inductance	$L_S$	Measured from the source pin, 6mm (0.25") from header & source bonding pad.	-	13	-	nH
Junction-to-Case	$R_{\theta JC}$		-	-	0.83	$^\circ\text{C/W}$
Case-to-Sink	$R_{\theta CS}$	Mounting surface flat, smooth and greased	-	0.1	-	$^\circ\text{C/W}$
Junction-to-Ambient	$R_{\theta JA}$	Free Air Operation	-	-	30	$^\circ\text{C/W}$



Source Drain Diode Ratings and Characteristics

Continuous Source Current (Body Diode)	$I_S$	Modified MOSFET symbol showing the integral reverse P-N junction rectifier.	-	-	-19	A
Pulse Source Current (Body Diode) (Note 3)	$I_{SM}$		-	-	-76	A
Diode Forward Voltage (Note 2)	$V_{SD}$	$T_J = +25^\circ\text{C}, I_S = -19A, V_{GS} = 0V$	-	-	-1.5	V
Reverse Recovery Time	$t_{rr}$	$T_J = +25^\circ\text{C}, I_F = -18A, di_F/dt = 100A/\mu s$	-	210	-	ns
Reverse Recovered Charge	$Q_{RR}$		-	2.0	-	$\mu\text{C}$
Forward Turn-on Time	$t_{ON}$	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$ .	-	-	-	-

NOTES: 1.  $T_J = +25^\circ\text{C}$  to  $+150^\circ\text{C}$   
 2. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$   
 3. Repetitive Rating: Pulse width limited by max. junction temperature. See Transient Thermal Impedance Curve (Figure 5)  
 4.  $V_{DD} = 60V$ , Start  $T_J = +25^\circ\text{C}$ ,  $L = 4.2\text{mH}$ ,  $R_G = 25\Omega$ , Peak  $I_L = 19A$  (See Figures 15 and 16)

IRFP9140R, IRFP9141R, IRFP9142R, IRFP9143R

T-39-23

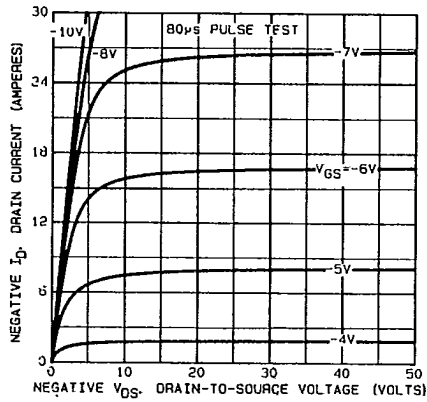


Fig. 1 - Typical output characteristics.

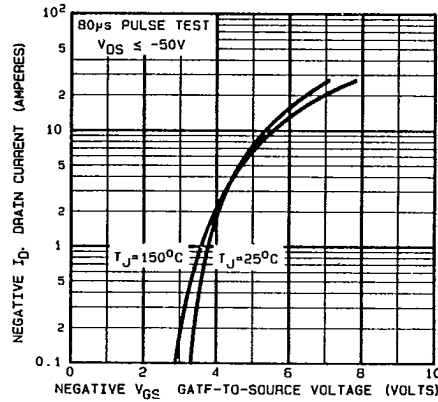


Fig. 2 - Typical transfer characteristics.

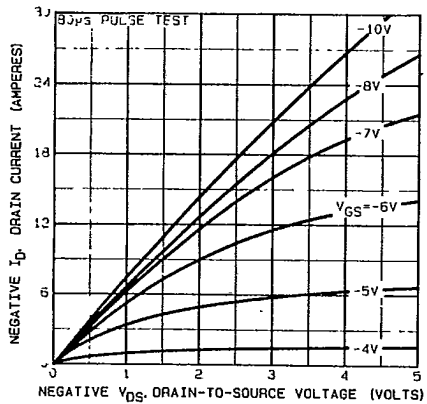


Fig. 3 - Typical saturation characteristics.

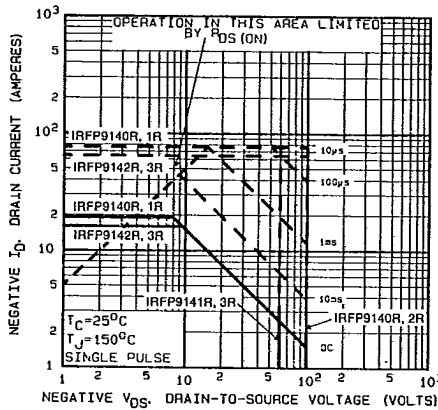


Fig. 4 - Maximum safe operating area.

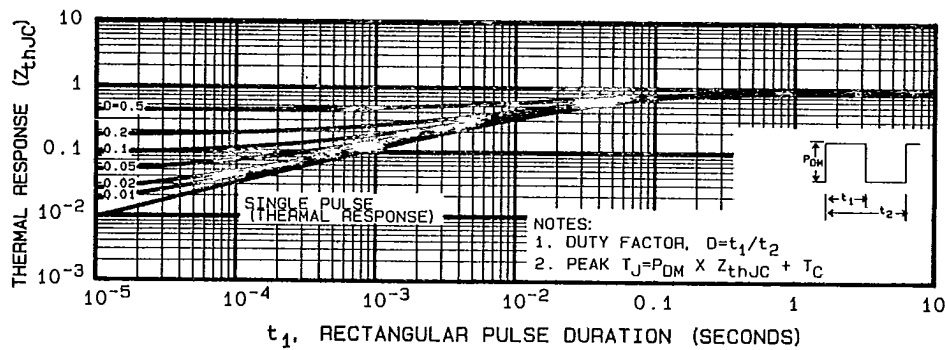


Fig. 5 - Maximum effective transient thermal impedance, junction-to-case vs. pulse duration.

IRFP9140R, IRFP9141R, IRFP9142R, IRFP9143R

T-39-23

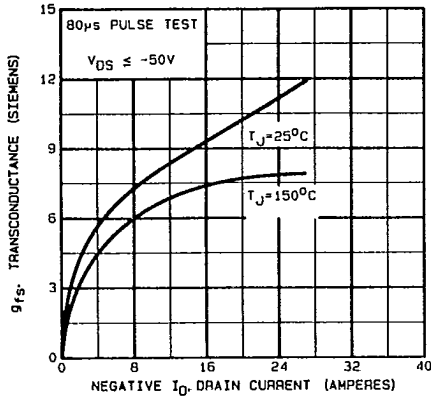


Fig. 6 - Typical transconductance vs. drain current.

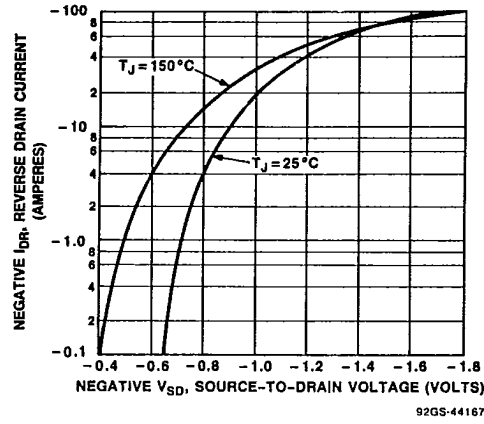


Fig. 7 - Typical source-drain diode forward voltage.

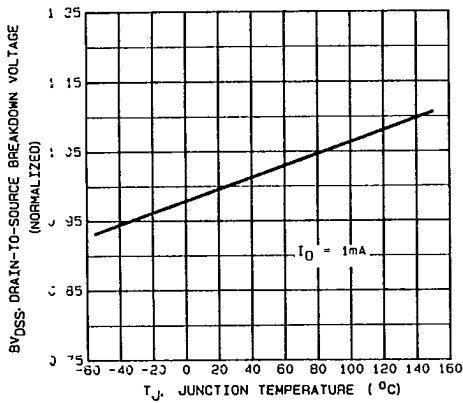


Fig. 8 - Breakdown voltage vs. temperature.

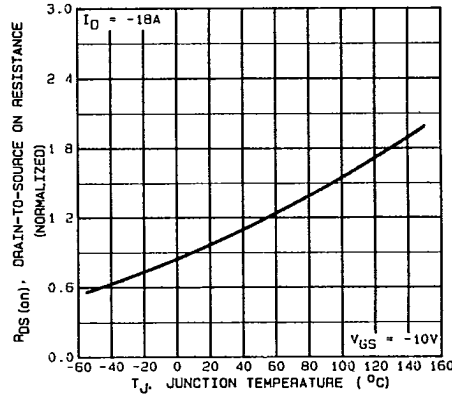


Fig. 9 - Normalized on-resistance vs. temperature.

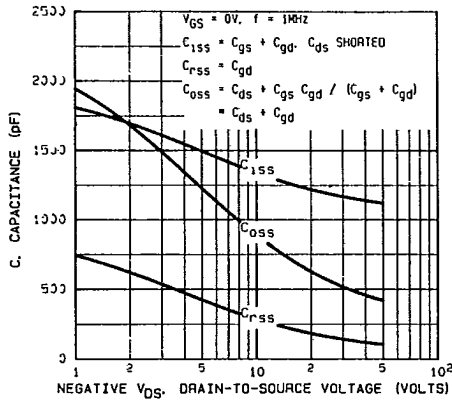


Fig. 10 - Typical capacitance vs. drain-to-source voltage.

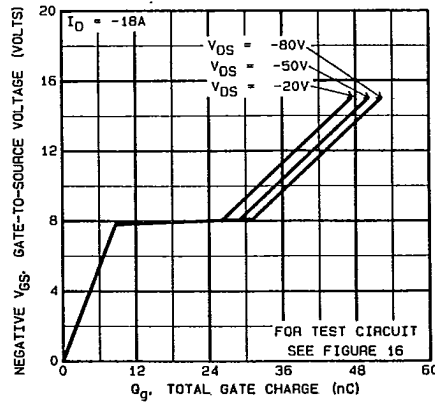


Fig. 11 - Typical gate charge vs. gate-to-source voltage.



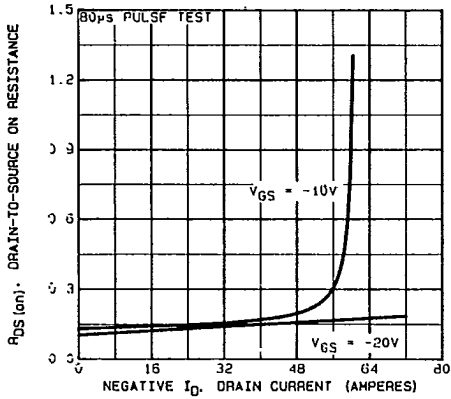


Fig. 12 - Typical on-resistance vs. drain current.

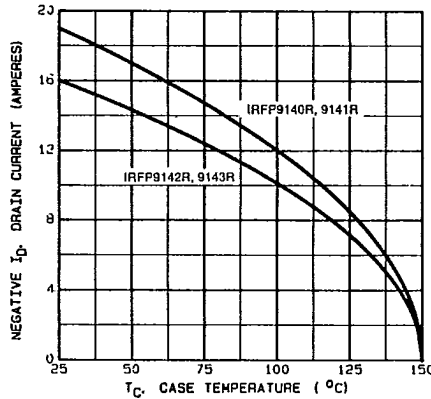


Fig. 13 - Maximum drain current vs. case temperature.

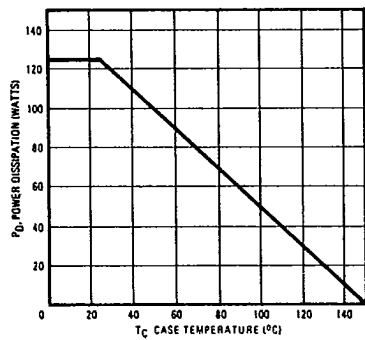


Fig. 14 - Power vs. temperature derating curve.

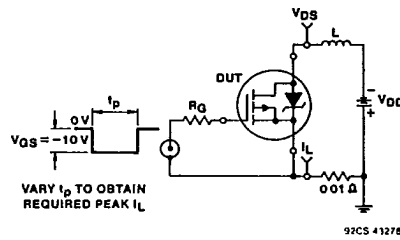


Fig. 15 - Unclamped inductive test circuit.

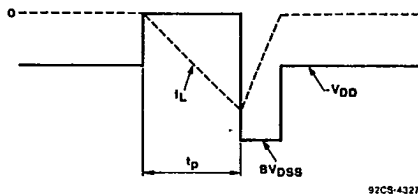


Fig. 16 - Unclamped inductive waveforms.

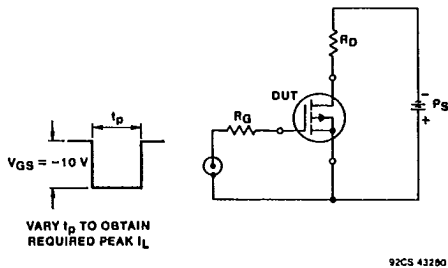


Fig. 17 - Switching time test circuit.

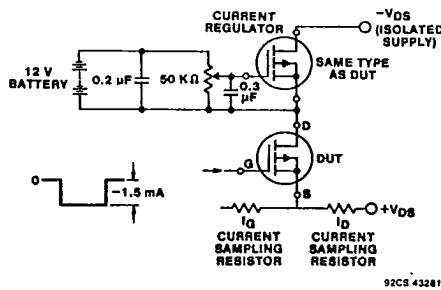


Fig. 18 - Gate charge test circuit.